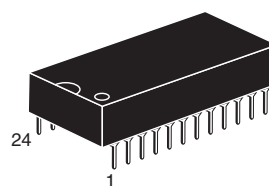


**5 V, 16 Kbit (2 Kb x 8) ZEROPOWER<sup>®</sup> SRAM****Features**

- Integrated, ultra low power SRAM and power-fail control circuit
- Unlimited WRITE cycles
- READ cycle time equals WRITE cycle time
- Automatic power-fail chip deselect and WRITE protection
- WRITE protect voltages ( $V_{\text{PFD}}$  = power-fail deselect voltage):
  - M48Z02:  $V_{\text{CC}} = 4.75$  to  $5.5$  V;  
 $4.5$  V  $\leq V_{\text{PFD}} \leq 4.75$  V
  - M48Z12:  $V_{\text{CC}} = 4.5$  to  $5.5$  V;  
 $4.2$  V  $\leq V_{\text{PFD}} \leq 4.5$  V
- Self-contained battery in the CAPHAT<sup>™</sup> DIP package
- Pin and function compatible with JEDEC standard 2 K x 8 SRAMs
- RoHS compliant
  - Lead-free second level interconnect



PCDIP24  
Battery CAPHAT<sup>™</sup>

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# 1 Description

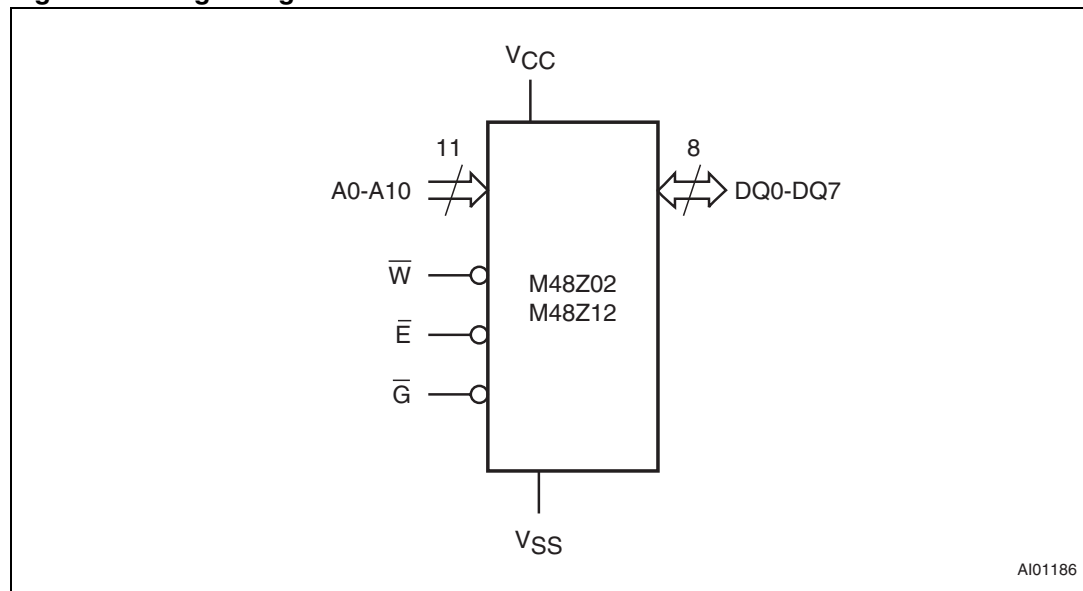
The M48Z02/12 ZEROPOWER<sup>®</sup> RAM is a 2 K x 8 non-volatile static RAM which is pin and function compatible with the DS1220.

A special 24-pin, 600 mil DIP CAPHAT<sup>™</sup> package houses the M48Z02/12 silicon with a long-life lithium button cell to form a highly integrated battery-backed memory solution.

The M48Z02/12 button cell has sufficient capacity and storage life to maintain data functionality for an accumulated time period of at least 10 years in the absence of power over commercial operating temperature range.

The M48Z02/12 is a non-volatile pin and function equivalent to any JEDEC standard 2 K x 8 SRAM. It also easily fits into many ROM, EPROM, and EEPROM sockets, providing the non-volatility of PROMs without any requirement for special WRITE timing or limitations on the number of WRITES that can be performed.

**Figure 1. Logic diagram**



**Table 1. Signal names**

A0-A10	Address inputs
DQ0-DQ7	Data inputs / outputs
$\bar{E}$	Chip enable
$\bar{G}$	Output enable
$\bar{W}$	WRITE enable
V <sub>CC</sub>	Supply voltage
V <sub>SS</sub>	Ground

Figure 2. DIP connections

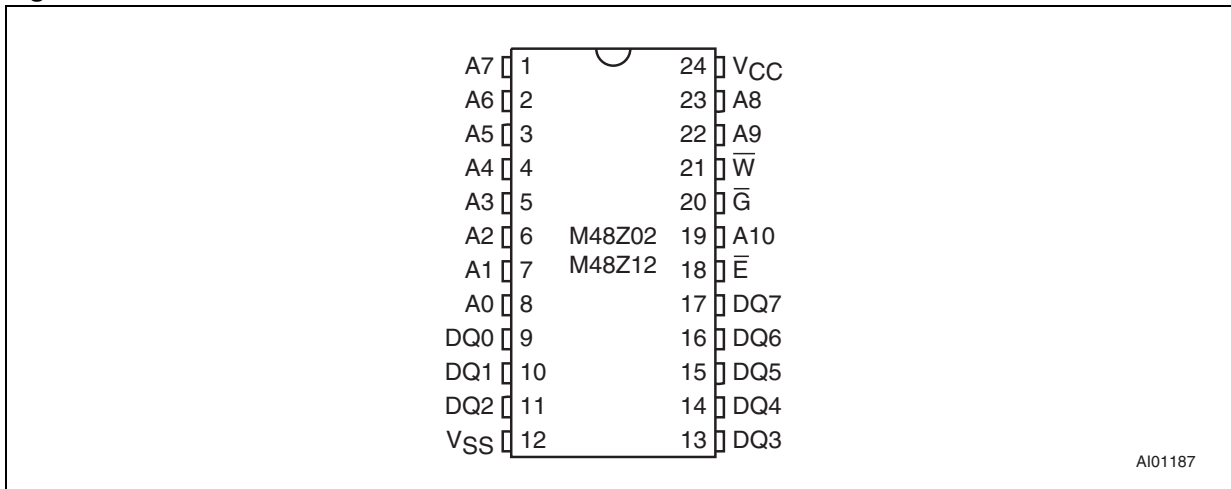
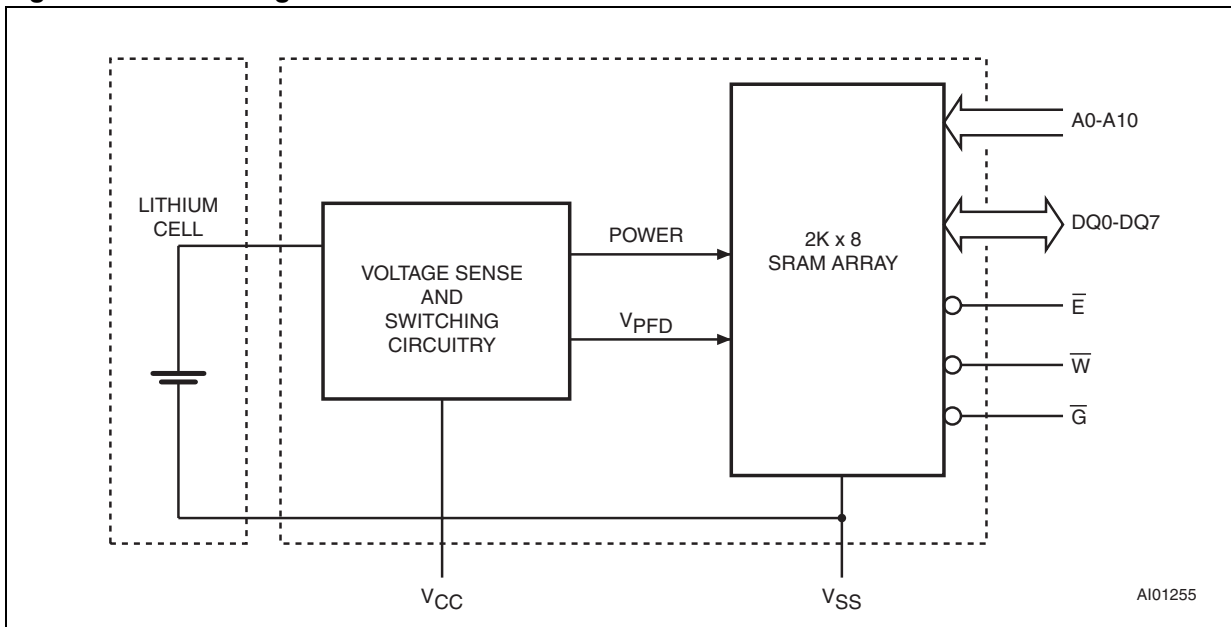


Figure 3. Block diagram



## 2 Operation modes

The M48Z02/12 also has its own power-fail detect circuit. The control circuitry constantly monitors the single 5 V supply for an out of tolerance condition. When  $V_{CC}$  is out of tolerance, the circuit write protects the SRAM, providing a high degree of data security in the midst of unpredictable system operation brought on by low  $V_{CC}$ . As  $V_{CC}$  falls below approximately 3 V, the control circuitry connects the battery which maintains data operation until valid power returns.

**Table 2. Operating modes**

Mode	$V_{CC}$	$\bar{E}$	$\bar{G}$	$\bar{W}$	DQ0-DQ7	Power
Deselect	4.75 to 5.5 V or 4.5 to 5.5 V	$V_{IH}$	X	X	High Z	Standby
WRITE		$V_{IL}$	X	$V_{IL}$	$D_{IN}$	Active
READ		$V_{IL}$	$V_{IL}$	$V_{IH}$	$D_{OUT}$	Active
READ		$V_{IL}$	$V_{IH}$	$V_{IH}$	High Z	Active
Deselect	$V_{SO}$ to $V_{PFD}(\min)^{(1)}$	X	X	X	High Z	CMOS standby
Deselect	$\leq V_{SO}^{(1)}$	X	X	X	High Z	Battery backup mode

1. See [Table 10 on page 16](#) for details.

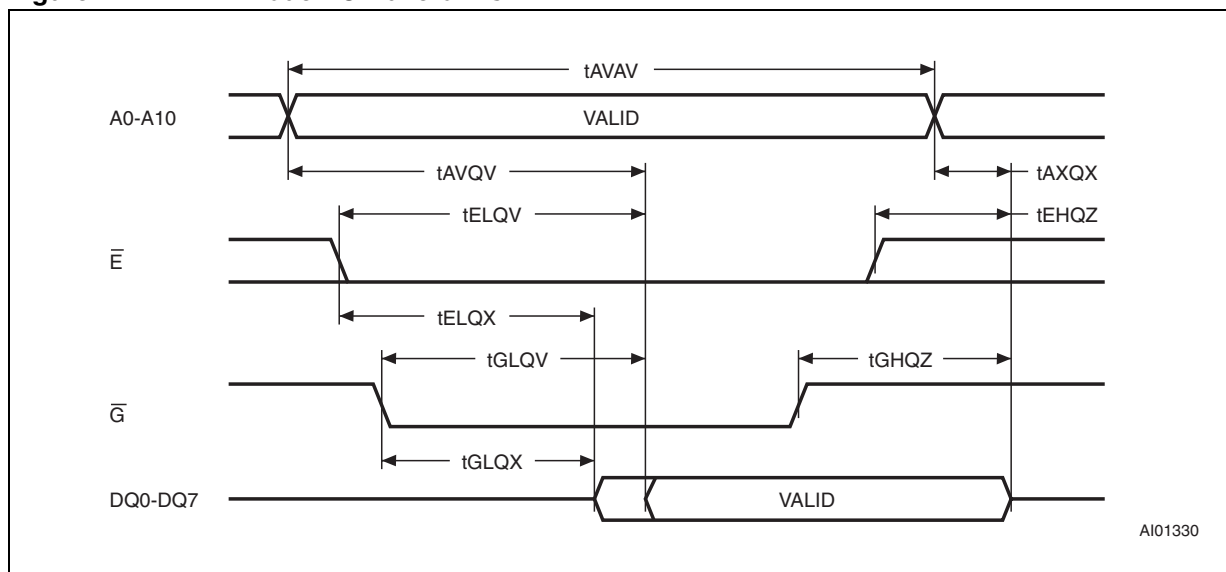
*Note:*  $X = V_{IH}$  or  $V_{IL}$ ;  $V_{SO}$  = battery backup switchover voltage.

### 2.1 READ mode

The M48Z02/12 is in the READ mode whenever  $\bar{W}$  (WRITE enable) is high and  $\bar{E}$  (chip enable) is low. The device architecture allows ripple-through access of data from eight of 16,384 locations in the static storage array. Thus, the unique address specified by the 11 Address Inputs defines which one of the 2,048 bytes of data is to be accessed. Valid data will be available at the data I/O pins within address access time ( $t_{AVQV}$ ) after the last address input signal is stable, providing that the  $\bar{E}$  and  $\bar{G}$  access times are also satisfied. If the  $\bar{E}$  and  $\bar{G}$  access times are not met, valid data will be available after the latter of the chip enable access time ( $t_{ELQV}$ ) or output enable access time ( $t_{GLQV}$ ).

The state of the eight three-state data I/O signals is controlled by  $\bar{E}$  and  $\bar{G}$ . If the outputs are activated before  $t_{AVQV}$ , the data lines will be driven to an indeterminate state until  $t_{AVQV}$ . If the address inputs are changed while  $\bar{E}$  and  $\bar{G}$  remain active, output data will remain valid for output data hold time ( $t_{AXQX}$ ) but will go indeterminate until the next address access.

Figure 4. READ mode AC waveforms



Note: WRITE enable ( $\bar{W}$ ) = high.

Table 3. READ mode AC characteristics

Symbol	Parameter <sup>(1)</sup>	M48Z02/M48Z12						Unit
		-70		-150		-200		
		Min	Max	Min	Max	Min	Max	
$t_{AVAV}$	READ cycle time	70		150		200		ns
$t_{AVQV}$	Address valid to output valid		70		150		200	ns
$t_{ELQV}$	Chip enable low to output valid		70		150		200	ns
$t_{GLQV}$	Output enable low to output valid		35		75		80	ns
$t_{ELQX}$	Chip enable low to output transition	5		10		10		ns
$t_{GLQX}$	Output enable low to output transition	5		5		5		ns
$t_{EHQZ}$	Chip enable high to output Hi-Z		25		35		40	ns
$t_{GHQZ}$	Output enable high to output Hi-Z		25		35		40	ns
$t_{AXQX}$	Address transition to output transition	10		5		5		ns

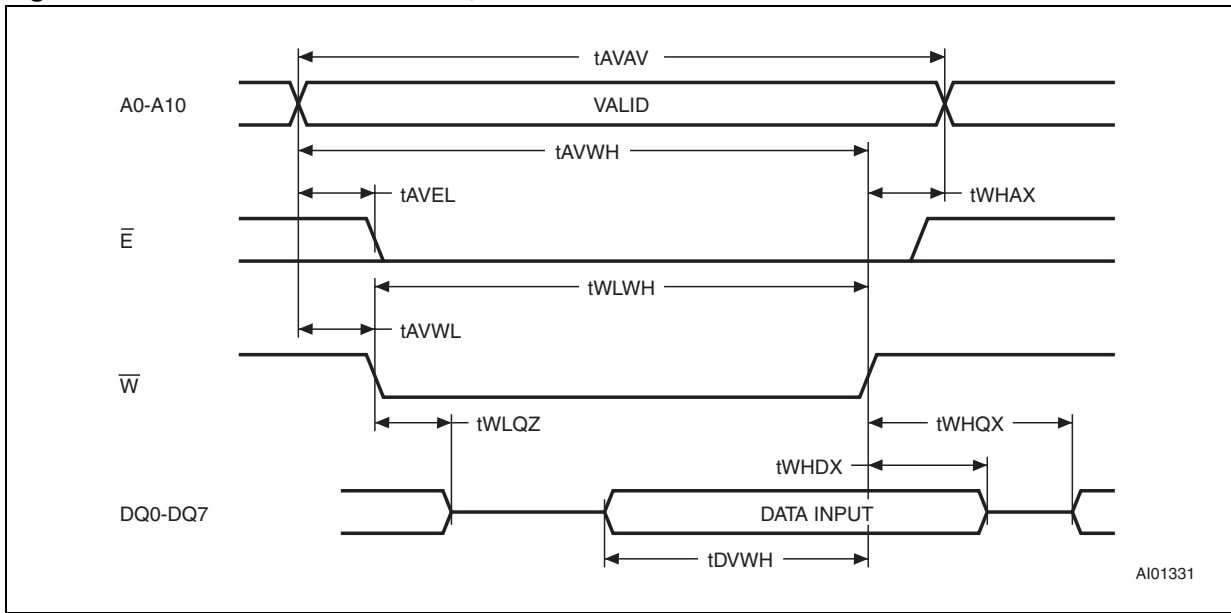
1. Valid for ambient operating temperature:  $T_A = 0$  to  $70$  °C or  $-40$  to  $85$  °C;  $V_{CC} = 4.75$  to  $5.5$  V or  $4.5$  to  $5.5$  V (except where noted).

## 2.2 WRITE mode

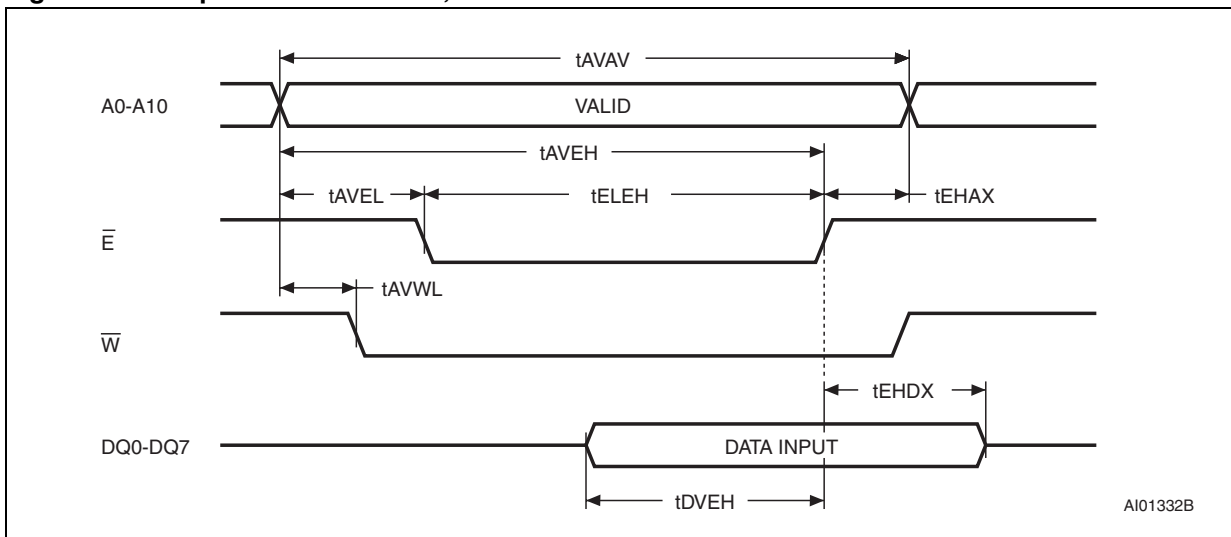
The M48Z02/12 is in the WRITE mode whenever  $\bar{W}$  and  $\bar{E}$  are active. The start of a WRITE is referenced from the latter occurring falling edge of  $\bar{W}$  or  $\bar{E}$ . A WRITE is terminated by the earlier rising edge of  $\bar{W}$  or  $\bar{E}$ . The addresses must be held valid throughout the cycle.  $\bar{E}$  or  $\bar{W}$  must return high for a minimum of  $t_{EHAX}$  from chip enable or  $t_{WHAX}$  from WRITE enable prior to the initiation of another READ or WRITE cycle. Data-in must be valid  $t_{DVWH}$  prior to the end of WRITE and remain valid for  $t_{WHDX}$  afterward.  $\bar{G}$  should be kept high during WRITE cycles to avoid bus contention; although, if the output bus has been activated by a low on  $\bar{E}$  and  $\bar{G}$ , a low on  $\bar{W}$  will disable the outputs  $t_{WLQZ}$  after  $\bar{W}$  falls.



**Figure 5. WRITE enable controlled, WRITE AC waveform**



**Figure 6. Chip enable controlled, WRITE AC waveforms**



**Table 4. WRITE mode AC characteristics**

Symbol	Parameter <sup>(1)</sup>	M48Z02/M48Z12						Unit
		-70		-150		-200		
		Min	Max	Min	Max	Min	Max	
t <sub>AVAV</sub>	WRITE cycle time	70		150		200		ns
t <sub>AVWL</sub>	Address valid to WRITE enable low	0		0		0		ns
t <sub>AVEL</sub>	Address valid to chip enable 1 low	0		0		0		ns
t <sub>WLWH</sub>	WRITE enable pulse width	50		90		120		ns
t <sub>ELEH</sub>	Chip enable low to chip enable 1 high	55		90		120		ns
t <sub>WHAX</sub>	WRITE enable high to address transition	0		10		10		ns
t <sub>EHAX</sub>	Chip enable high to address transition	0		10		10		ns
t <sub>DVWH</sub>	Input valid to WRITE enable high	30		40		60		ns
t <sub>DVEH</sub>	Input valid to chip enable high	30		40		60		ns
t <sub>WHDX</sub>	WRITE enable high to input transition	5		5		5		ns
t <sub>EHDX</sub>	Chip enable high to input transition	5		5		5		ns
t <sub>WLQZ</sub>	WRITE enable low to output Hi-Z		25		50		60	ns
t <sub>AVWH</sub>	Address valid to WRITE enable high	60		120		140		ns
t <sub>AVEH</sub>	Address valid to chip enable high	60		120		140		ns
t <sub>WHQX</sub>	WRITE enable high to output transition	5		10		10		ns

1. Valid for ambient operating temperature: T<sub>A</sub> = 0 to 70 °C or -40 to 85 °C; V<sub>CC</sub> = 4.75 to 5.5 V or 4.5 to 5.5 V (except where noted).

### 2.3 Data retention mode

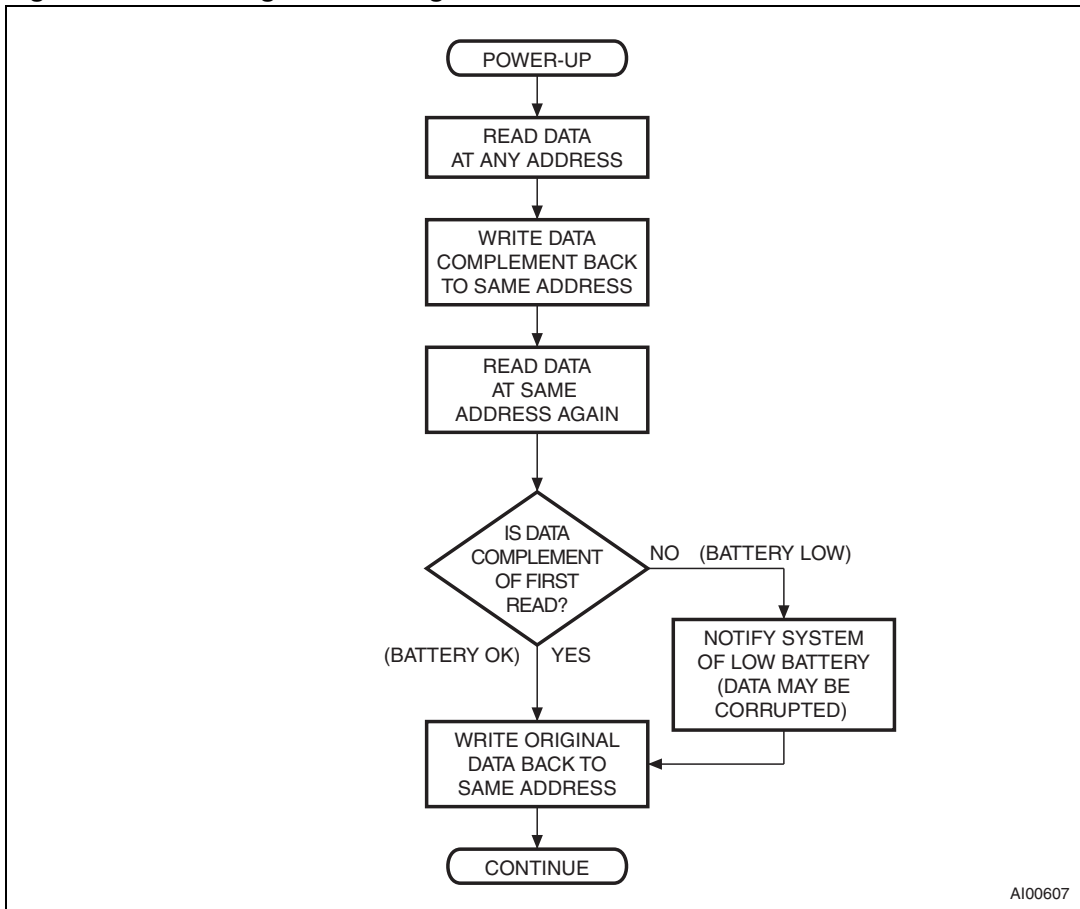
With valid V<sub>CC</sub> applied, the M48Z02/12 operates as a conventional BYTEWIDE™ static RAM. Should the supply voltage decay, the RAM will automatically power-fail deselect, write protecting itself when V<sub>CC</sub> falls within the V<sub>PFD</sub> (max), V<sub>PFD</sub> (min) window. All outputs become high impedance, and all inputs are treated as “don't care.”

*Note: A power failure during a WRITE cycle may corrupt data at the currently addressed location, but does not jeopardize the rest of the RAM's content. At voltages below V<sub>PFD</sub> (min), the user can be assured the memory will be in a write protected state, provided the V<sub>CC</sub> fall time is not less than t<sub>F</sub>. The M48Z02/12 may respond to transient noise spikes on V<sub>CC</sub> that reach into the deselect window during the time the device is sampling V<sub>CC</sub>. Therefore, decoupling of the power supply lines is recommended.*

The power switching circuit connects external V<sub>CC</sub> to the RAM and disconnects the battery when V<sub>CC</sub> rises above V<sub>SO</sub>. As V<sub>CC</sub> rises, the battery voltage is checked. If the voltage is too low, an internal Battery Not OK (BOK) flag will be set. The BOK flag can be checked after power up. If the BOK flag is set, the first WRITE attempted will be blocked. The flag is automatically cleared after the first WRITE, and normal RAM operation resumes. [Figure 7 on page 11](#) illustrates how a BOK check routine could be structured.

For more information on a battery storage life refer to the application note AN1012.

Figure 7. Checking the  $\overline{\text{BOK}}$  flag status

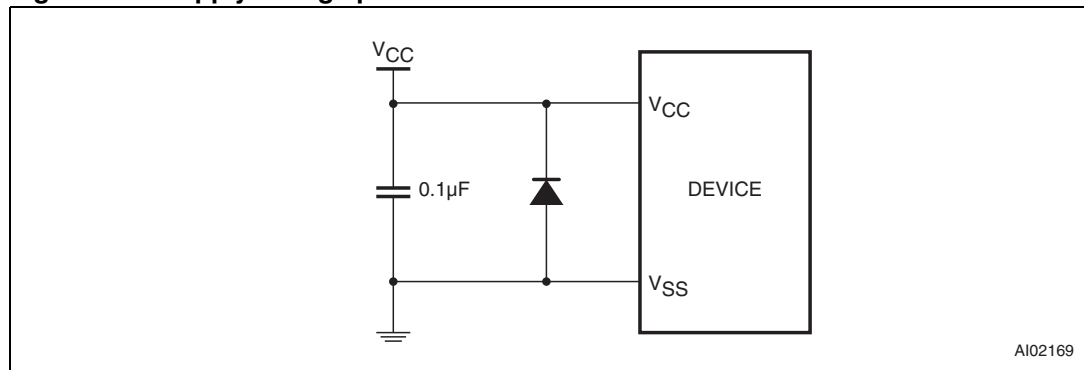


## 2.4 V<sub>CC</sub> noise and negative going transients

I<sub>CC</sub> transients, including those produced by output switching, can produce voltage fluctuations, resulting in spikes on the V<sub>CC</sub> bus. These transients can be reduced if capacitors are used to store energy which stabilizes the V<sub>CC</sub> bus. The energy stored in the bypass capacitors will be released as low going spikes are generated or energy will be absorbed when overshoots occur. A ceramic bypass capacitor value of 0.1 μF (as shown in [Figure 8](#)) is recommended in order to provide the needed filtering.

In addition to transients that are caused by normal SRAM operation, power cycling can generate negative voltage spikes on V<sub>CC</sub> that drive it to values below V<sub>SS</sub> by as much as one volt. These negative spikes can cause data corruption in the SRAM while in battery backup mode. To protect from these voltage spikes, STMicroelectronics recommends connecting a Schottky diode from V<sub>CC</sub> to V<sub>SS</sub> (cathode connected to V<sub>CC</sub>, anode to V<sub>SS</sub>). Schottky diode 1N5817 is recommended for through hole and MBR120T3 is recommended for surface mount.

**Figure 8. Supply voltage protection**



### 3 Maximum ratings

Stressing the device above the rating listed in the absolute maximum ratings table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**Table 5. Absolute maximum ratings**

Symbol	Parameter		Value	Unit
$T_A$	Ambient operating temperature	Grade 1	0 to 70	°C
$T_{STG}$	Storage temperature ( $V_{CC}$ off, oscillator off)		-40 to 85	°C
$T_{SLD}^{(1)}$	Lead solder temperature for 10 seconds		260	°C
$V_{IO}$	Input or output voltages		-0.3 to 7	V
$V_{CC}$	Supply voltage		-0.3 to 7	V
$I_O$	Output current		20	mA
$P_D$	Power dissipation		1	W

1. Soldering temperature of the IC leads is to not exceed 260 °C for 10 seconds. Furthermore, the devices shall not be exposed to IR reflow nor preheat cycles (as performed as part of wave soldering). ST recommends the devices be hand-soldered or placed in sockets to avoid heat damage to the batteries.

**Caution:** *Negative undershoots below -0.3 V are not allowed on any pin while in the battery backup mode.*

## 4 DC and AC parameters

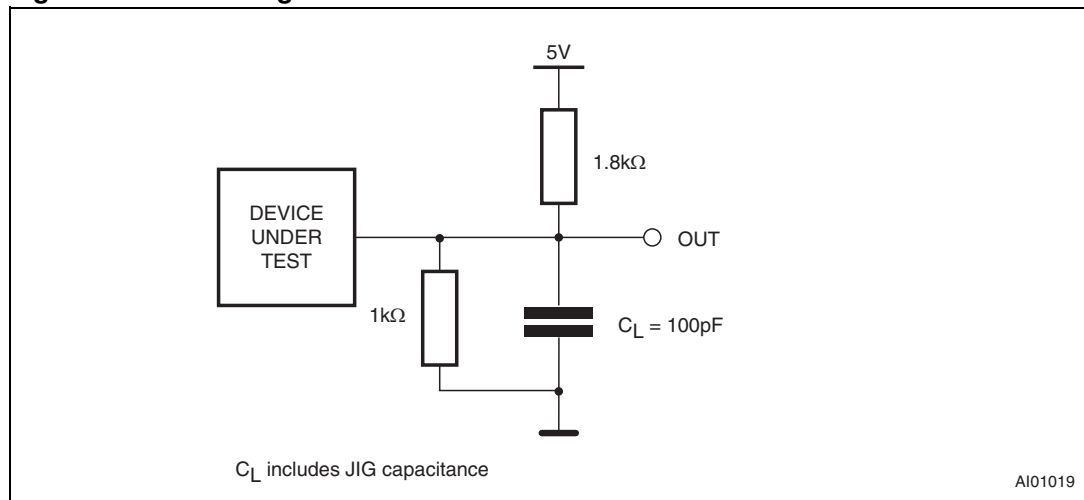
This section summarizes the operating and measurement conditions, as well as the DC and AC characteristics of the device. The parameters in the following DC and AC characteristic tables are derived from tests performed under the measurement conditions listed in [Table 6: Operating and AC measurement conditions](#). Designers should check that the operating conditions in their projects match the measurement conditions when using the quoted parameters.

**Table 6. Operating and AC measurement conditions**

Parameter		M48Z02	M48Z12	Unit
Supply voltage ( $V_{CC}$ )		4.75 to 5.5	4.5 to 5.5	V
Ambient operating temperature ( $T_A$ )	Grade 1	0 to 70	0 to 70	°C
Load capacitance ( $C_L$ )		100	100	pF
Input rise and fall times		≤ 5	≤ 5	ns
Input pulse voltages		0 to 3	0 to 3	V
Input and output timing ref. voltages		1.5	1.5	V

*Note:* Output Hi-Z is defined as the point where data is no longer driven.

**Figure 9. AC testing load circuit**



**Table 7. Capacitance**

Symbol	Parameter <sup>(1)(2)</sup>	Min	Max	Unit
$C_{IN}$	Input capacitance	-	10	pF
$C_{IO}^{(3)}$	Input / output capacitance	-	10	pF

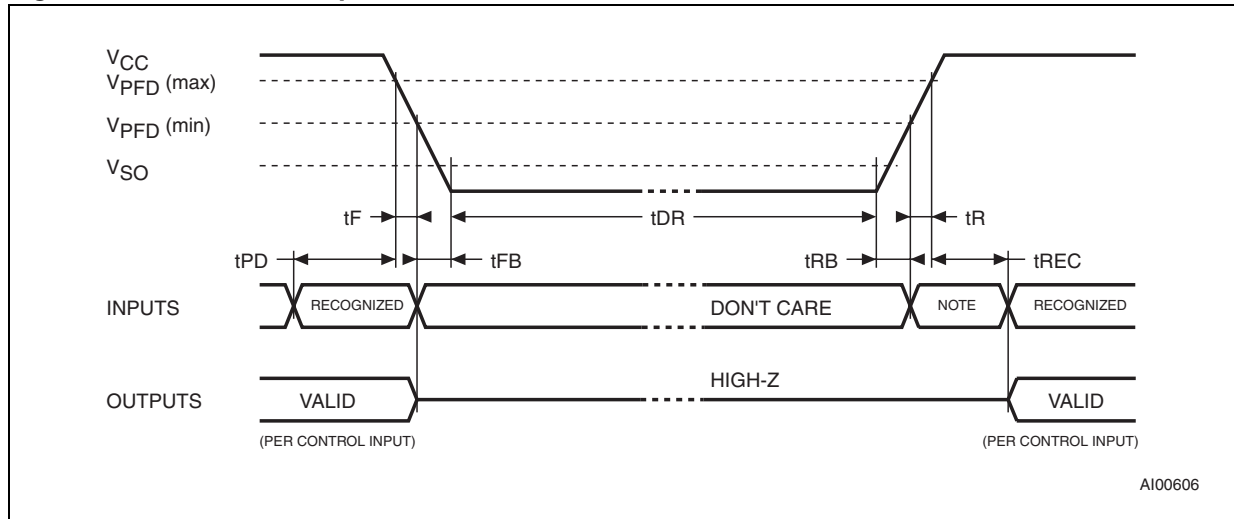
1. Effective capacitance measured with power supply at 5 V. Sampled only, not 100% tested.
2. At 25°C, f = 1 MHz.
3. Outputs deselected.

**Table 8. DC characteristics**

Symbol	Parameter	Test condition <sup>(1)</sup>	Min	Max	Unit
$I_{LI}$	Input leakage current	$0V \leq V_{IN} \leq V_{CC}$		$\pm 1$	$\mu A$
$I_{LO}^{(2)}$	Output leakage current	$0V \leq V_{OUT} \leq V_{CC}$		$\pm 1$	$\mu A$
$I_{CC}$	Supply current	Outputs open		80	mA
$I_{CC1}$	Supply current (standby) TTL	$\bar{E} = V_{IH}$		3	mA
$I_{CC2}$	Supply current (standby) CMOS	$\bar{E} = V_{CC} - 0.2 V$		3	mA
$V_{IL}$	Input low voltage		-0.3	0.8	V
$V_{IH}$	Input high voltage		2.2	$V_{CC} + 0.3$	V
$V_{OL}$	Output low voltage	$I_{OL} = 2.1 mA$		0.4	V
$V_{OH}$	Output high voltage	$I_{OH} = -1 mA$	2.4		V

- Valid for ambient operating temperature:  $T_A = 0$  to  $70$  °C;  $V_{CC} = 4.75$  to  $5.5$  V or  $4.5$  to  $5.5$  V (except where noted).
- Outputs deselected.

**Figure 10. Power down/up mode AC waveforms**



**Note:** *Inputs may or may not be recognized at this time. Caution should be taken to keep  $\bar{E}$  high as  $V_{CC}$  rises past  $V_{PFD} (min)$ . Some systems may perform inadvertent WRITE cycles after  $V_{CC}$  rises above  $V_{PFD} (min)$  but before normal system operations begin. Even though a power on reset is being applied to the processor, a reset condition may not occur until after the system is running.*

**Table 9. Power down/up AC characteristics**

Symbol	Parameter <sup>(1)</sup>	Min	Max	Unit
$t_{PD}$	$\overline{E}$ or $\overline{W}$ at $V_{IH}$ before power down	0	-	$\mu s$
$t_F^{(2)}$	$V_{PFD}$ (max) to $V_{PFD}$ (min) $V_{CC}$ fall time	300	-	$\mu s$
$t_{FB}^{(3)}$	$V_{PFD}$ (min) to $V_{SS}$ $V_{CC}$ fall time	10	-	$\mu s$
$t_R$	$V_{PFD}$ (min) to $V_{PFD}$ (max) $V_{CC}$ rise time	0	-	$\mu s$
$t_{RB}$	$V_{SS}$ to $V_{PFD}$ (min) $V_{CC}$ rise time	1	-	$\mu s$
$t_{REC}$	$\overline{E}$ or $\overline{W}$ at $V_{IH}$ after power up	2	-	ms

- Valid for ambient operating temperature:  $T_A = 0$  to  $70$  °C;  $V_{CC} = 4.75$  to  $5.5$  V or  $4.5$  to  $5.5$  V (except where noted).
- $V_{PFD}$  (max) to  $V_{PFD}$  (min) fall time of less than  $t_F$  may result in deselection/write protection not occurring until  $200$   $\mu s$  after  $V_{CC}$  passes  $V_{PFD}$  (min).
- $V_{PFD}$  (min) to  $V_{SS}$  fall time of less than  $t_{FB}$  may cause corruption of RAM data.

**Table 10. Power down/up trip points DC characteristics**

Symbol	Parameter <sup>(1)(2)</sup>	Min	Typ	Max	Unit	
$V_{PFD}$	Power-fail deselect voltage	M48Z02	4.5	4.6	4.75	V
		M48Z12	4.2	4.3	4.5	V
$V_{SO}$	Battery backup switchover voltage		3.0		V	
$t_{DR}^{(3)}$	Expected data retention time	10			YEARS	

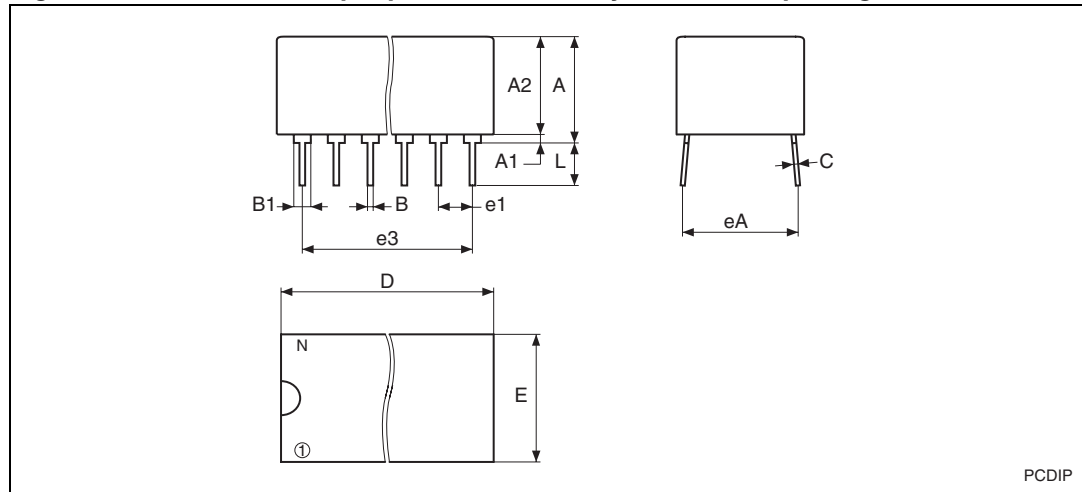
- All voltages referenced to  $V_{SS}$ .
- Valid for ambient operating temperature:  $T_A = 0$  to  $70$  °C;  $V_{CC} = 4.75$  to  $5.5$  V or  $4.5$  to  $5.5$  V (except where noted).
- At  $25$  °C,  $V_{CC} = 0$  V.



## 5 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

**Figure 11. PCDIP24 – 24-pin plastic DIP, battery CAPHAT™, package outline**

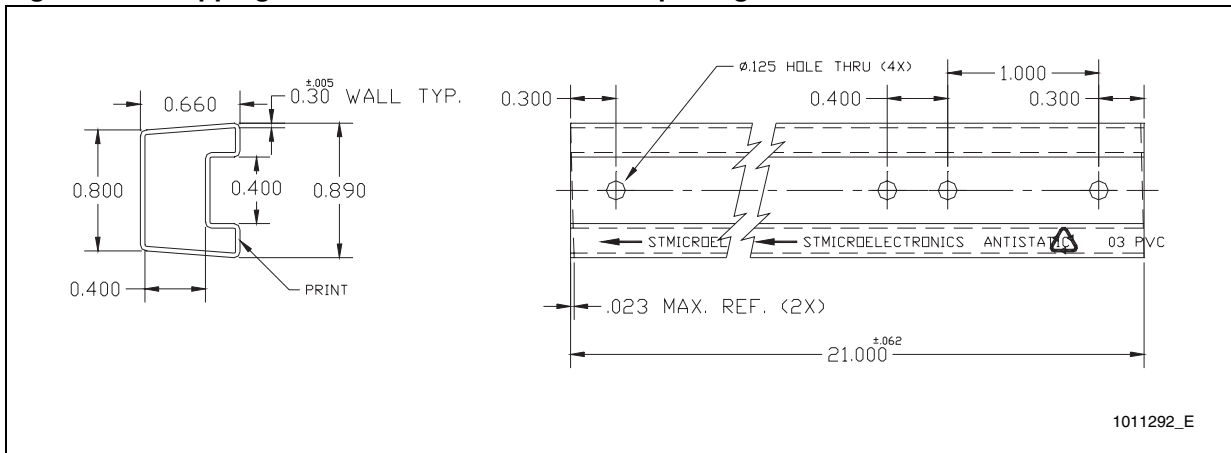


*Note:* Drawing is not to scale.

**Table 11. PCDIP24 – 24-pin plastic DIP, battery CAPHAT™, package mechanical data**

Symb	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A		8.89	9.65		0.350	0.380
A1		0.38	0.76		0.015	0.030
A2		8.38	8.89		0.330	0.350
B		0.38	0.53		0.015	0.021
B1		1.14	1.78		0.045	0.070
C		0.20	0.31		0.008	0.012
D		34.29	34.80		1.350	1.370
E		17.83	18.34		0.702	0.722
e1		2.29	2.79		0.090	0.110
e3	27.94			1.1		
eA		15.24	16.00		0.600	0.630
L		3.05	3.81		0.120	0.150
N		24			24	

Figure 12. Shipping tube dimensions for PCDIP24 package



Note: All dimensions are in inches.

## 6 Part numbering

**Table 12. Ordering information scheme**

Example:	M48Z	02	-70	PC	1
<b>Device type</b>					
M48Z					
<b>Supply voltage and write protect voltage</b>					
02 = $V_{CC} = 4.75$ to $5.5$ V; $V_{PFD} = 4.5$ to $4.75$ V					
12 = $V_{CC} = 4.5$ to $5.5$ V; $V_{PFD} = 4.2$ to $4.5$ V					
<b>Speed</b>					
-70 = 70 ns (M48Z02/12)					
-150 = 150 ns (M48Z02/12)					
-200 = 200 ns (M48Z02/12) <sup>(1)</sup>					
<b>Package</b>					
PC = PCDIP24					
<b>Temperature range</b>					
1 = 0 to 70 °C					

1. Not recommended for new design. Contact local ST sales office for availability.

For a list of available options (e.g., speed, package) or for further information on any aspect of this device, please contact the ST sales office nearest you.

## 7 Environmental information

Figure 13. Recycling symbols



This product contains a non-rechargeable lithium (lithium carbon monofluoride chemistry) button cell battery fully encapsulated in the final product.

Recycle or dispose of batteries in accordance with the battery manufacturer's instructions and local/national disposal and recycling regulations.

## 8 Revision history

**Table 13. Document revision history**

Date	Revision	Changes
May-1999	1	First issue
09-Jul-2001	2	Reformatted; temperature information added to tables ( <a href="#">Table 5</a> , <a href="#">6</a> , <a href="#">7</a> , <a href="#">8</a> , <a href="#">3</a> , <a href="#">4</a> , <a href="#">9</a> , <a href="#">10</a> ); Figure updated ( <a href="#">Figure 10</a> )
17-Dec-2001	2.1	Remove references to “clock” in document
20-May-2002	2.2	Updated V <sub>CC</sub> noise and negative going transients text
01-Apr-2003	3	v2.2 template applied; test condition updated ( <a href="#">Table 10</a> )
22-Apr-2003	3.1	Fix error in ordering information ( <a href="#">Table 12</a> )
12-Dec-2005	4	Update template, Lead-free text, and remove references to ‘crystal’ and footnote ( <a href="#">Table 8</a> , <a href="#">12</a> )
02-Nov-2007	5	Reformatted document; added lead-free second level interconnect information to cover page and <a href="#">Section 5: Package mechanical data</a> ; updated <a href="#">Table 5</a> , <a href="#">6</a> , <a href="#">8</a> , <a href="#">9</a> , <a href="#">10</a> , <a href="#">12</a> .
03-Dec-2008	6	Added <a href="#">Section 7: Environmental information</a> ; minor formatting changes.
27-May-2010	7	Updated <a href="#">Section 3</a> , <a href="#">Table 11</a> , text in <a href="#">Section 5</a> ; reformatted document.
21-Jan-2011	8	Updated <a href="#">Table 12: Ordering information scheme</a> for 200 ns version of devices; updated <a href="#">Section 7</a> ; added <a href="#">Figure 12</a> ; minor textual updates.
07-Jun-2011	9	Updated footnote of <a href="#">Table 5: Absolute maximum ratings</a> .

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